

March 2008

FDMS3662

N-Channel Power Trench[®] MOSFET 100V, 49A, 14.8m Ω

Features

- Max $r_{DS(on)} = 14.8 \text{m}\Omega$ at $V_{GS} = 10 \text{V}$, $I_D = 8.9 \text{A}$
- Advanced Package and Silicon combination for low r_{DS(on)}
- MSL1 robust package design
- 100% UIL Tested
- RoHS Compliant

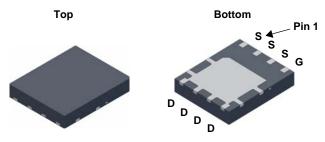


General Description

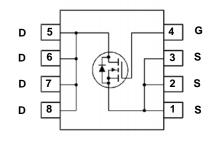
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Application

■ DC - DC Conversion







MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units		
V _{DS}	Drain to Source Voltage			100	V	
V_{GS}	Gate to Source Voltage			±20	V	
	Drain Current -Continuous (Package limited)	T _C = 25°C		49		
	-Continuous (Silicon limited)	T _C = 25°C		57	_	
I _D	-Continuous	T _A = 25°C	(Note 1a)	8.9	Α	
	-Pulsed			90		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	384	mJ	
Б	Power Dissipation	T _C = 25°C		104	W	
P_{D}	Power Dissipation $T_A = 25^{\circ}C$ (Note 1a)		(Note 1a)	2.5	VV	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C	

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		1.2	°C/W
R _{e.IA}	Thermal Resistance, Junction to Ambient	(Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS3662	FDMS3662	Power 56	13"	12mm	3000 units

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, referenced to 25°C		74		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 80V,$			1	μΑ
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu A$	2.5	3.5	4.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		-10.8		mV/°C
-	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 8.9A$		11.4	14.8	mΩ
r _{DS(on)} Static Drain to Source On Resistance	$V_{GS} = 10V$, $I_D = 8.9A$, $T_J = 125$ °C		19.0	24.7	11152	
g _{FS}	Forward Transconductance	$V_{DD} = 10V, I_D = 8.9A$		37		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 50V V 0V	3470	4620	pF
C _{oss}	Output Capacitance	$V_{DS} = 50V, V_{GS} = 0V,$ f = 1MHz	245	325	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112	110	165	pF
R_g	Gate Resistance	f = 1MHz	1.4		Ω

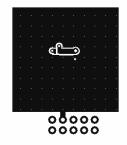
Switching Characteristics

t _{d(on)}	Turn-On Delay Time		25	40	ns
t _r	Rise Time	$V_{DD} = 50V, I_D = 8.9A,$	15	26	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 6\Omega$	32	52	ns
t _f	Fall Time		6	10	ns
Qg	Total Gate Charge at 10V		54	75	nC
Q _{gs}	Gate to Source Charge	$V_{DD} = 50V,$ $I_{D} = 8.9A$	18		nC
Q _{gd}	Gate to Drain "Miller" Charge	ID = 0.3A	15		nC

Drain-Source Diode Characteristics

V Source	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 8.9A$ (Note 2)	0.8	1.3	V
V SD	Source to Drain Diode Forward voltage	$V_{GS} = 0V, I_S = 2.1A$ (Note 2)	0.7	1.2	
t _{rr}	Reverse Recovery Time	I _E = 8.9A, di/dt = 100A/μs	45	73	ns
Q _{rr}	Reverse Recovery Charge	- I _F = 8.9A, αι/αι = 100A/μS	71	115	nC

^{1.} $R_{\theta JA}$ is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 50°C/W when mounted on a 1 in² pad of 2 oz copper.



b. 125°C/W when mounted on a minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < 300μs, Duty cycle < 2.0%.

^{3.} Starting T_J = 25°C, L = 3mH, I_{AS} = 16A, V_{DD} = 100V, V_{GS} = 10V

Typical Characteristics T_J = 25°C unless otherwise noted

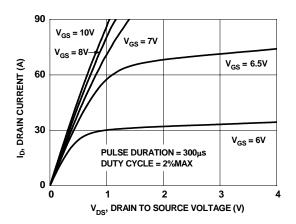


Figure 1. On-Region Characteristics

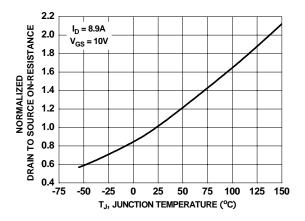


Figure 3. Normalized On-Resistance vs Junction Temperature

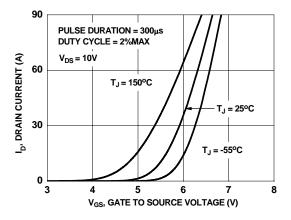


Figure 5. Transfer Characteristics

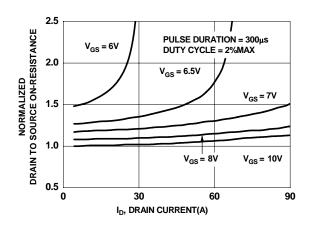


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

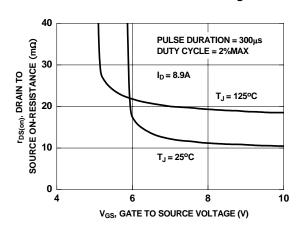


Figure 4. On-Resistance vs Gate to Source Voltage

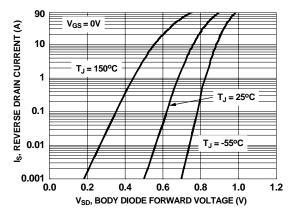


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

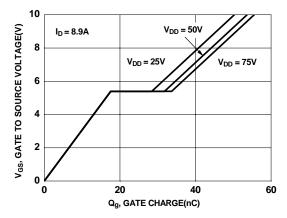


Figure 7. Gate Charge Characteristics

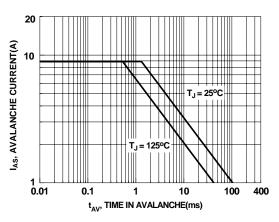


Figure 9. Unclamped Inductive Switching Capability

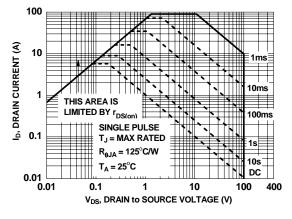


Figure 11. Forward Bias Safe Operating Area

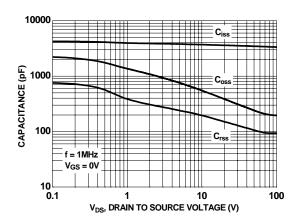


Figure 8. Capacitance vs Drain to Source Voltage

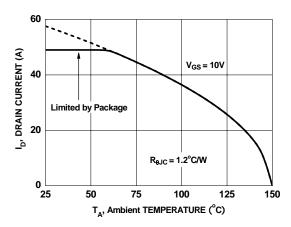


Figure 10. Maximum Continuous Drain Current vs Case Temperature

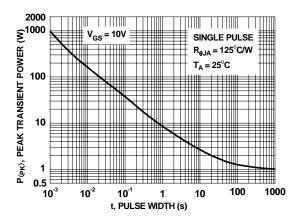


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25°C unless otherwise noted

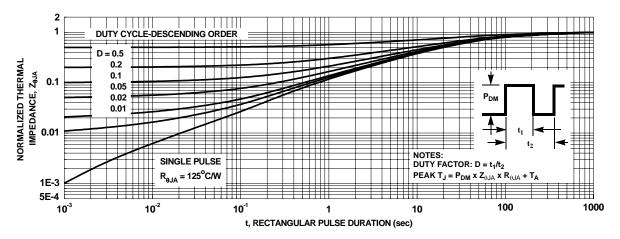
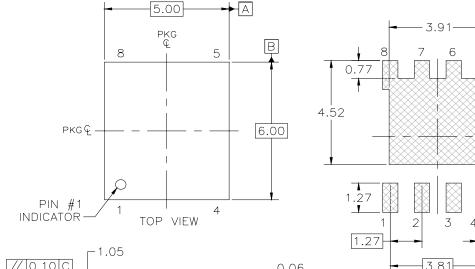


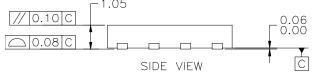
Figure 13. Transient Thermal Response Curve

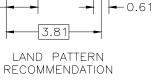
-1.27

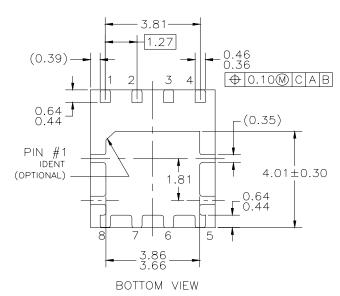
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Dimensional Outline and Pad Layout









- NOTES: UNLESS OTHERWISE SPECIFIED

 A) ALL DIMENSIONS ARE IN MILLIMETERS.
 - B)

 - NO JEDEC REFERENCE AS OF FEBRUARY 2006 DIMENSIONING AND TOLERANCING PER ASME Y14.5M 1994

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